

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/608,477 | Applicant(s)/Patent Under Reexamination MARCUS MARANHÃO | |
| | Examiner Steven HD Nguyen | Art Unit 2665 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,647,117 | 11-2003 | Wallace et al. | 379/395.01 |
| | B | US-6,526,581 | 02-2003 | Edson, Richard | 725/111 |
| | C | US-6,522,647 | 02-2003 | Czajkowski et al. | 370/356 |
| | D | US-2002/0006137 | 01-2002 | Rabenko et al. | 370/352 |
| | E | US-6,563,816 | 05-2003 | Nodoushani et al. | 370/352 |
| | F | US-6,456,633 | 09-2002 | Chen, Abraham Y. | 370/352 |
| | G | US-2001/0012293 | 08-2001 | PETERSEN et al. | 370/389 |
| | H | US-6,453,040 | 09-2002 | Burke et al. | 379/395.01 |
| | I | US-6,580,710 | 06-2003 | Bowen et al. | 370/353 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

RJ